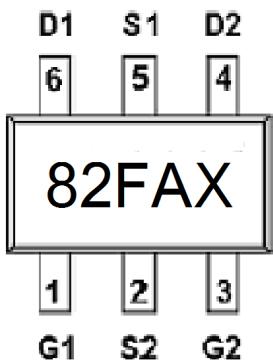


DESCRIPTION

STN8822A is the dual N-Channel enhancement mode power field effect transistor which is produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application, such as notebook computer power management and other battery powered circuits, where high-side switching is required.

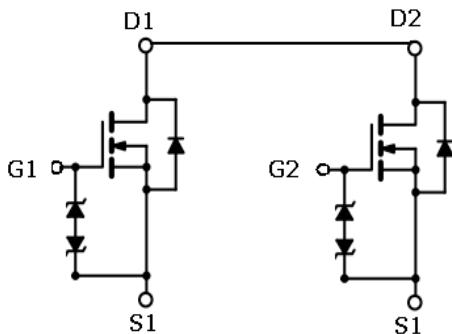
PIN CONFIGURATION TSOP-6



F: Year Code
A: Produces Code
X: Wafer Code

FEATURE

- 20V/6.0A, $R_{DS(ON)} = 25\text{m-ohm}$ @ $V_{GS} = 4.5\text{V}$
- 20V/5.0A, $R_{DS(ON)} = 42\text{m-ohm}$ @ $V_{GS} = 2.5\text{V}$
- Super high density cell design for extremely low $R_{DS(ON)}$
- Exceptional low on-resistance and maximum DC current capability
- TSOP-6 package design





STN8822A 

Dual N Channel Enhancement Mode MOSFET

6.0A

ABSOULTE MAXIMUM RATINGS (Ta = 25°C unless otherwise noted)

Parameter	Symbol	Typical	Unit
Drain-Source Voltage	V _{DSS}	20	V
Gate-Source Voltage	V _{GSS}	+/-10	V
Continuous Drain Current (T _J =150°C)	I _D	6.0	A
		3.4	
Pulsed Drain Current	I _{DM}	15	A
Continuous Source Current (Diode Conduction)	I _S	1.5	A
Power Dissipation	P _D	2.0	W
		1.2	
Operation Junction Temperature	T _J	-40/140	°C
Storage Temperature Range	T _{STG}	-55/150	°C
Thermal Resistance-Junction to Ambient	R _{θJA}	105	°C/W



STN8822A

Dual N Channel Enhancement Mode MOSFET

6.0A

ELECTRICAL CHARACTERISTICS (Ta = 25°C unless otherwise noted)

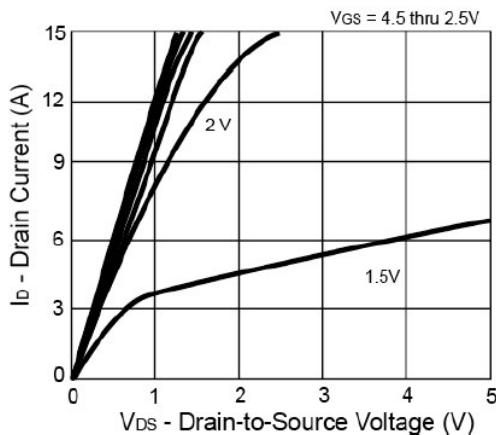
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =250uA	20			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250uA	0.6		1.0	V
Gate Leakage Current	I _{GSS}	V _{DS} =0V, V _{GS} =+/-10V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =20V, V _{GS} =0V			1	uA
		V _{DS} =20V, V _{GS} =0V T _J =85°C			5	
On-State Drain Current	I _{D(on)}	V _{DS} \leq 5V, V _{GS} =4.5V	6			A
Drain-source On-Resistance	R _{D(on)}	V _{GS} =4.5V, I _D =6.0A		0.020	0.025	Ω
		V _{GS} =2.5V, I _D =5.0A		0.032	0.042	
Forward Transconductance	g _{fs}	V _{DS} =5V, I _D =3.6A		30		S
Diode Forward Voltage	V _{SD}	I _s =1.7A, V _{GS} =0V		0.8	1.2	V

Dynamic

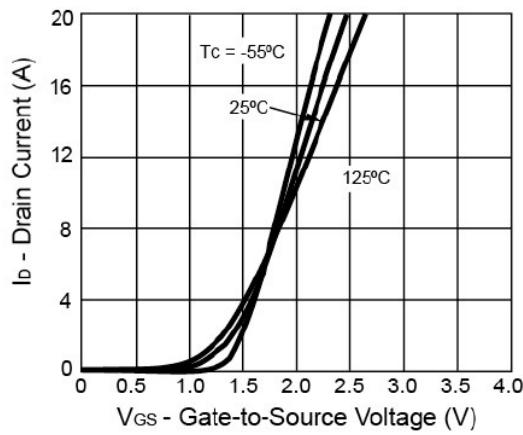
Total Gate Charge	Q _g	V _{DS} =10V, V _{GS} =4.5V, I _D =6.0A		4		nC
Gate-Source Charge	Q _{gs}			2.5		
Gate-Drain Charge	Q _{gd}			2.1		
Input Capacitance	C _{iss}	V _{DS} =8V, V _{GS} =0V f=1MHz		575		pF
Output Capacitance	C _{oss}			330		
Reverse Transfer Capacitance	C _{rss}			140		
Turn-On Time	T _{d(on)} t _r			14		nS
Turn-Off Time	T _{d(off)} t _f	V _{DD} =10V, RL=10Ω, I _D =1.0A, V _{GEN} =4.5V, RG=6Ω		16		
				35		
				30		

TYPICAL CHARACTERISTICS

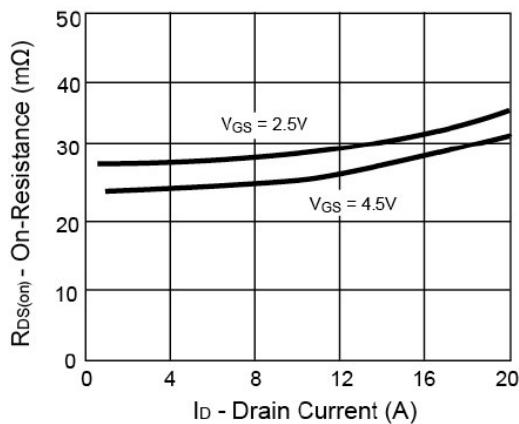
Output Characteristics



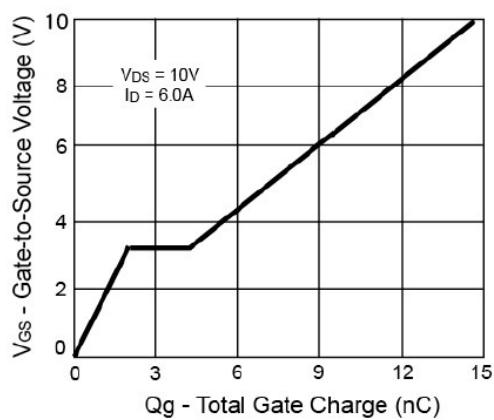
Transfer Characteristics



On-Resistance vs. Drain Current

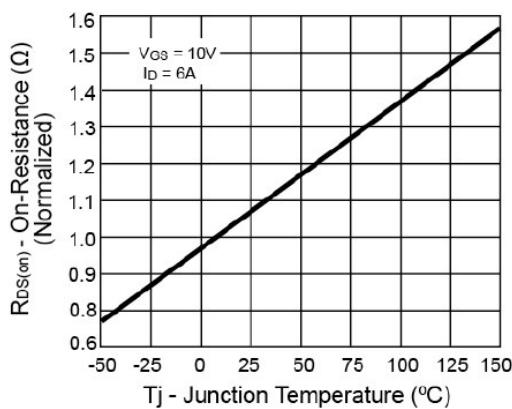


Gate Charge

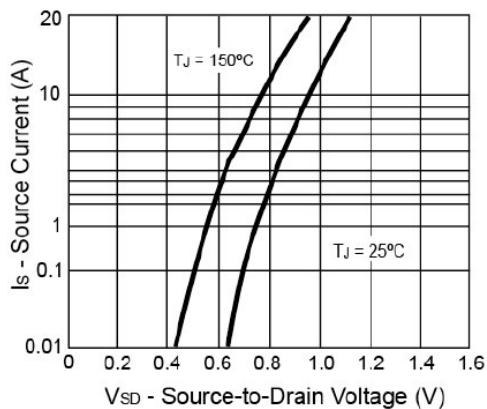


TYPICAL CHARACTERISTICS

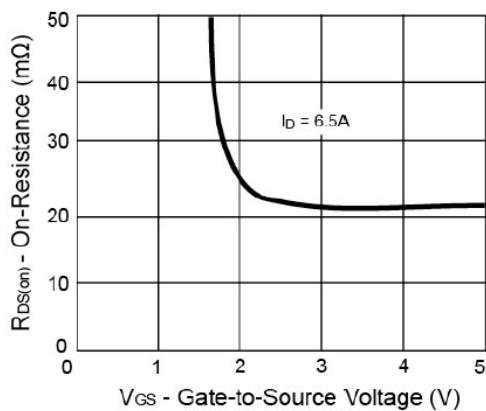
On-Resistance vs. Junction Temperature



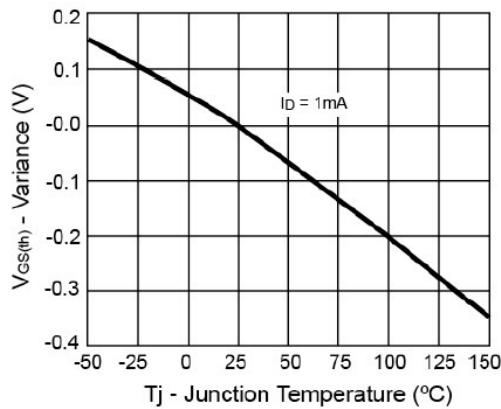
Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-Source Voltage

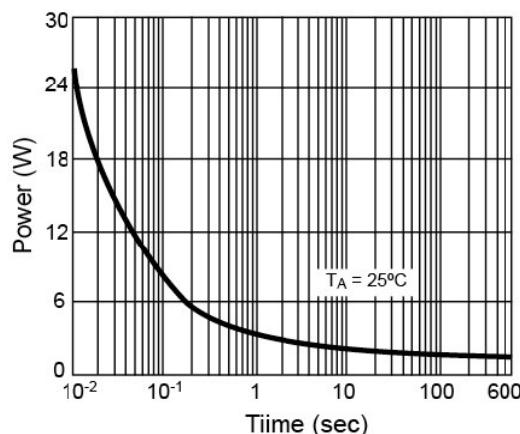


Threshold Voltage

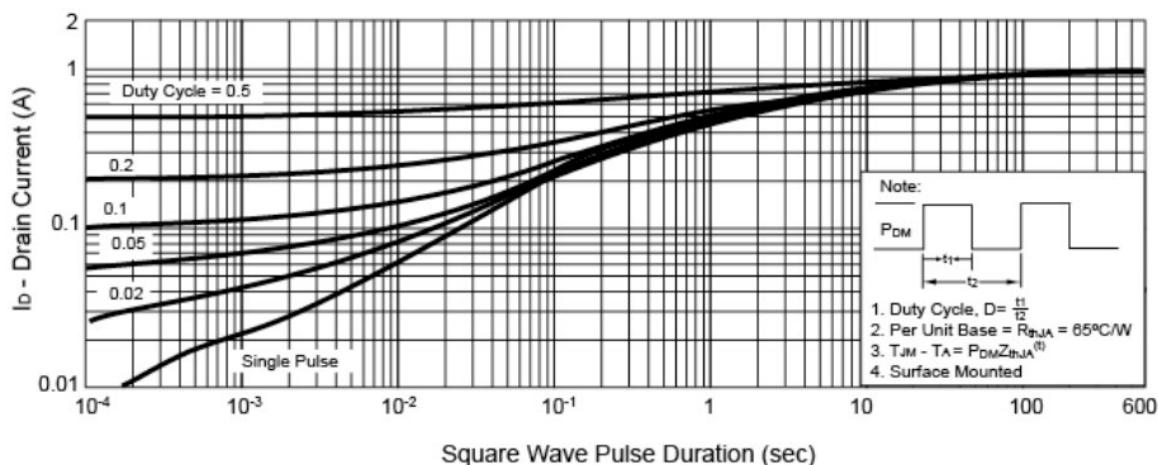


TYPICAL CHARACTERISTICS

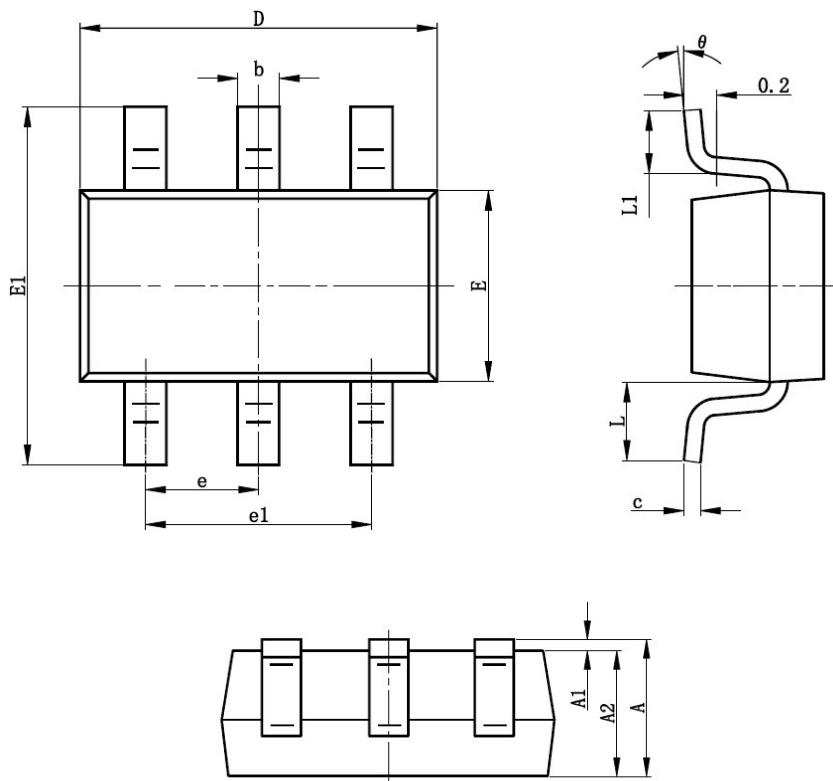
Single Pulse Power



Normalized Thermal Transient Impedance, Junction-to-Ambient



TSOP-6 PACKAGE OUTLINE



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.400	0.012	0.016
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	1.500	1.700	0.059	0.067
E1	2.650	2.950	0.104	0.116
e	0.950TYP		0.037TYP	
e1	1.800	2.000	0.071	0.079
L	0.700REF		0.028REF	
L1	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°